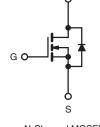
**Vishay Siliconix** 

# **Power MOSFET**

| PRODUCT SUMMARY            |                        |       |  |  |
|----------------------------|------------------------|-------|--|--|
| V <sub>DS</sub> (V)        | 250                    |       |  |  |
| R <sub>DS(on)</sub> (Ω)    | V <sub>GS</sub> = 10 V | 0.075 |  |  |
| Q <sub>g</sub> (Max.) (nC) | 210                    |       |  |  |
| Q <sub>gs</sub> (nC)       | 35                     |       |  |  |
| Q <sub>gd</sub> (nC)       | 98                     |       |  |  |
| Configuration              | Single                 |       |  |  |

# **TO-247**

D



N-Channel MOSFET

#### **FEATURES**

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- · Lead (Pb)-free Available

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

| ORDERING INFORMATION |             |
|----------------------|-------------|
| Package              | TO-247      |
| Lead (Pb)-free       | IRFP264PbF  |
|                      | SiHFP264-E3 |
| SnPb                 | IRFP264     |
|                      | SiHFP264    |

| <b>ABSOLUTE MAXIMUM RATINGS</b> T                | c = 25 °C, u            | nless otherv                      | vise noted      |                  |          |  |
|--|-------------------------|-----------------------------------|-----------------|------------------|----------|--|
| PARAMETER  |                         |                                   | SYMBOL          | LIMIT            | UNIT     |  |
| Drain-Source Voltage                             |                         |                                   | V <sub>DS</sub> | 250              | v        |  |
| Gate-Source Voltage                              |                         |                                   | V <sub>GS</sub> | ± 20             |          |  |
| Continuous Drain Current                         | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C            | I <sub>D</sub>  | 38               |          |  |
|  |                         | T <sub>C</sub> = 100 °C           |                 | 24               | А        |  |
| Pulsed Drain Currenta                            |                         |                                   | I <sub>DM</sub> | 150              | 1        |  |
| Linear Derating Factor                           |                         |                                   |                 | 2.2              | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>       |                         |                                   | E <sub>AS</sub> | 1000             | mJ       |  |
| Repetitive Avalanche Currenta                    |                         |                                   | I <sub>AR</sub> | 38               | A        |  |
| Repetitive Avalanche Energy <sup>a</sup>         |                         |                                   | E <sub>AR</sub> | 28               | mJ       |  |
| Maximum Power Dissipation                        | T <sub>C</sub> = 25 °C  |                                   | PD              | 280              | W        |  |
| Peak Diode Recovery dV/dtc                       |                         |                                   | dV/dt           | 4.8              | V/ns     |  |
| Operating Junction and Storage Temperature Range |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150   | °C               |          |  |
| Soldering Recommendations (Peak Temperature)     | for 10 s                |                                   |                 | 300 <sup>d</sup> |          |  |
| Mounting Torque                                  | 6-32 or M3 screw        |                                   |                 | 10               | lbf ⋅ in |  |
|  |                         |                                   |                 | 1.1              | N · m    |  |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 1.1 mH,  $R_G = 25 \Omega$ ,  $I_{AS} = 38$  A (see fig. 12).

c.  $I_{SD} \leq 38$  A, dI/dt  $\leq 210$  A/µs,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150$  °C.

d. 1.6 mm from case.

Document Number: 91217

S-81264-Rev. A, 21-Jul-08

\* Pb containing terminations are not RoHS compliant, exemptions may apply





Vishay Siliconix



| PARAMETER                                      | SYMBOL                 | TYP.  | MAX  |           |        | UNIT  |      |  |
|--|------------------------|---|--|-----------|--------|-------|------|--|
| Maximum Junction-to-Ambient                    | R <sub>thJA</sub>      | -   | 40   |           |        | °C/W  |      |  |
| Case-to-Sink, Flat, Greased Surface            | R <sub>thCS</sub>      | 0.24  | -  |           |        |       |      |  |
| Maximum Junction-to-Case (Drain)               | R <sub>thJC</sub>      | -   | 0.45   | 5         |        |       |      |  |
|  |                        |   |  |           |        |       |      |  |
| <b>SPECIFICATIONS</b> $T_J = 25 \ ^{\circ}C$ , | unless other           | wise noted  |  |           |        |       |      |  |
| PARAMETER                                      | SYMBOL                 | TEST  | MIN.   | TYP.      | MAX.   | UNI   |      |  |
| Static   |                        |   |  |           |        |       |      |  |
| Drain-Source Breakdown Voltage                 | V <sub>DS</sub>        | $V_{GS} = 0$  | V, I <sub>D</sub> = 250 μA   | 250       | -      | -     | v    |  |
| V <sub>DS</sub> Temperature Coefficient        | $\Delta V_{DS}/T_J$    | Reference to 25 °C, I <sub>D</sub> = 1 mA   |  | -         | 0.37   | -     | V/°0 |  |
| Gate-Source Threshold Voltage                  | V <sub>GS(th)</sub>    | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$  |  | 2.0       | -      | 4.0   | V    |  |
| Gate-Source Leakage                            | I <sub>GSS</sub>       | $V_{GS} = \pm 20 \text{ V}$   |  | -         | -      | ± 100 | nA   |  |
| Zero Gate Voltage Drain Current                |                        | V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V  |  | -         | -      | 25    | μA   |  |
|  | I <sub>DSS</sub>       | V <sub>DS</sub> = 200 V, V  | 00 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                             |           | -      | 250   |      |  |
| Drain-Source On-State Resistance               | R <sub>DS(on)</sub>    | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 23 A <sup>b</sup>   | -         | -      | 0.075 | Ω    |  |
| Forward Transconductance                       | <b>g</b> <sub>fs</sub> | V <sub>DS</sub> = 5   | 50 V, I <sub>D</sub> = 23 A <sup>b</sup>   | 20        | -      | -     | S    |  |
| Dynamic  |                        | 1   |  |           |        |       |      |  |
| Input Capacitance                              | C <sub>iss</sub>       |   |  | -         | 5400   | -     | pF   |  |
| Output Capacitance                             | Coss                   |   | $V_{GS} = 0 V,$<br>$V_{DS} = 25 V,$  |           | 870    | -     |      |  |
| Reverse Transfer Capacitance                   | C <sub>rss</sub>       | f = 1.0 MHz, see fig. 5   |  | -         | 150    | -     |      |  |
| Total Gate Charge                              | Qg                     |   |  | -         | -      | 210   | nC   |  |
| Gate-Source Charge                             | Q <sub>gs</sub>        | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 38 A, V <sub>DS</sub> = 200 V<br>see fig. 6 and 13 <sup>b</sup> | , _       | -      | 35    |      |  |
| Gate-Drain Charge                              | Q <sub>gd</sub>        | _   | see lig. 6 and 13  | -         | -      | 98    |      |  |
| Turn-On Delay Time                             | t <sub>d(on)</sub>     |   |  | -         | 22     | -     |      |  |
| Rise Time                                      | t <sub>r</sub>         |   |  | -         | 99     | -     | 1    |  |
| Turn-Off Delay Time                            | t <sub>d(off)</sub>    | $V_{DD} = 125 \text{ V}, \text{ I}_{D} = 38 \text{ A}, \\ R_{G} = 4.3 \Omega, R_{D} = 3.2 \Omega, \text{ see fig. } 10^{b}$ |  | -         | 110    | -     | ns   |  |
| Fall Time                                      | t <sub>f</sub>         |   |  | -         | 92     | -     |      |  |
| Internal Drain Inductance                      | L <sub>D</sub>         | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact  |  | -         | 5.0    | -     | nH   |  |
| Internal Source Inductance                     | L <sub>S</sub>         |   |  | -         | 13     | -     |      |  |
| Drain-Source Body Diode Characteristic         | s                      | ·   |  |           |        |       | •    |  |
| Continuous Source-Drain Diode Current          | I <sub>S</sub>         | MOSFET symbol<br>showing the<br>integral reverse<br>p - n junction diode  |  | -         | -      | 38    | A    |  |
| Pulsed Diode Forward Current <sup>a</sup>      | I <sub>SM</sub>        |   |  | -         | -      | 150   |      |  |
| Body Diode Voltage                             | $V_{SD}$               | $T_{J} = 25 \ ^{\circ}C, \ I_{S} = 38 \ A, \ V_{GS} = 0 \ V^{b}$  |  | -         | -      | 1.8   | V    |  |
| Body Diode Reverse Recovery Time               | t <sub>rr</sub>        | $T_{\rm J} = 25 \ ^{\circ}\text{C}, I_{\rm F} = 38 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{\rm b}$                    |  | -         | 410    | 620   | ns   |  |
| Body Diode Reverse Recovery Charge             | Q <sub>rr</sub>        |   |  | -         | 5.7    | 8.6   | μC   |  |
| Forward Turn-On Time                           | t <sub>on</sub>        | Intrinsic turn  | rn-on is dor   | minated b | vlsand | 5     |      |  |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



Vishay Siliconix

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

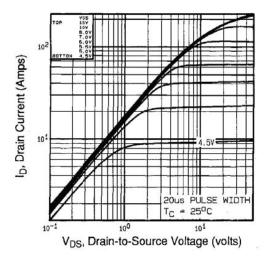


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

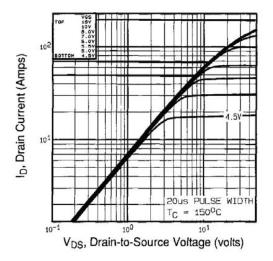


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

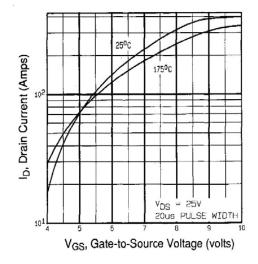


Fig. 3 - Typical Transfer Characteristics

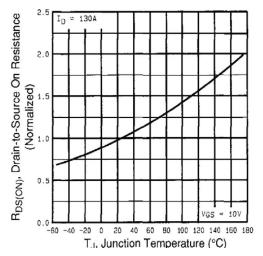


Fig. 4 - Normalized On-Resistance vs. Temperature

Vishay Siliconix



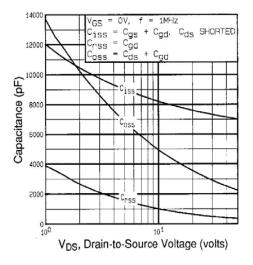


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

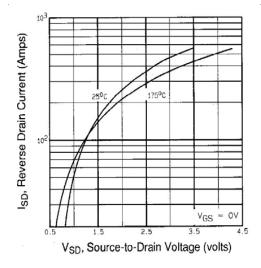


Fig. 7 - Typical Source-Drain Diode Forward Voltage

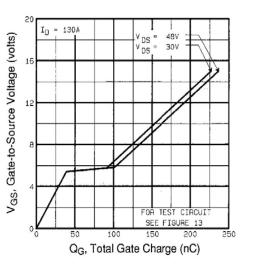


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

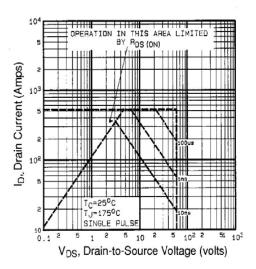


Fig. 8 - Maximum Safe Operating Area



### Vishay Siliconix

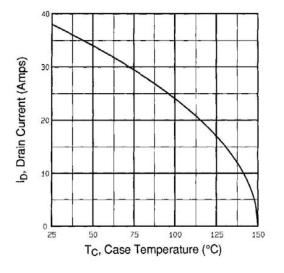


Fig. 9 - Maximum Drain Current vs. Case Temperature

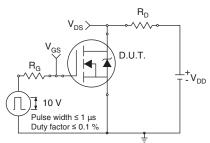


Fig. 10a - Switching Time Test Circuit

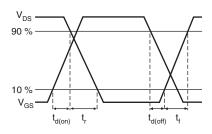
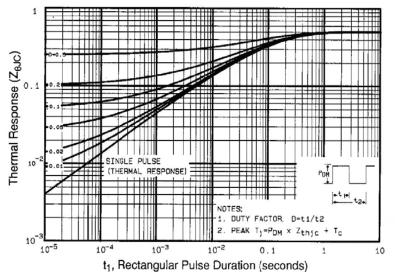
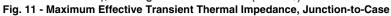


Fig. 10b - Switching Time Waveforms





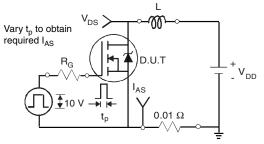
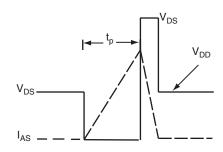
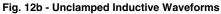


Fig. 12a - Unclamped Inductive Test Circuit





## Vishay Siliconix



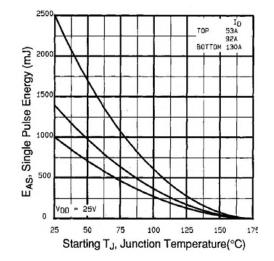


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

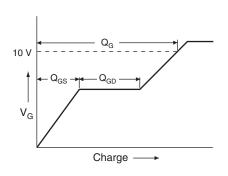
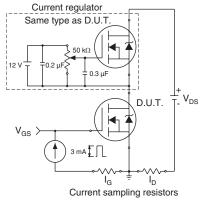


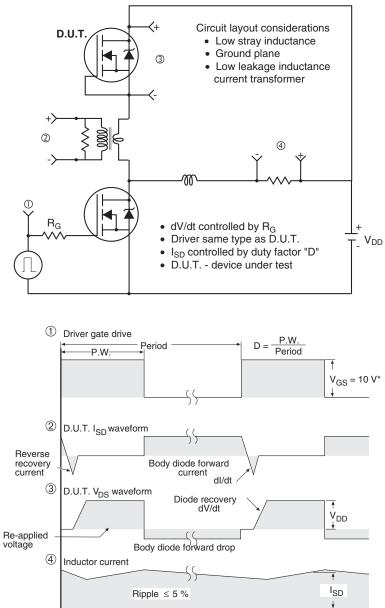
Fig. 13a - Basic Gate Charge Waveform





**Vishay Siliconix** 





Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91217.



Vishay

## Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.